Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/756,606	KURAHASHI ET AL.	
Examiner	Art Unit	
Lucy P. Chien	2871	

SEARCHED					
Class	Subclass	Date	Examiner		
349	39	6/10/2005	LC		
349	141	6/10/2005	LC		
			<u> </u>		
		•			

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
		·				
l	j					

(INCLUDING SEARCH	SIRAIEGT)
	DATE	EXMR
349/39,141.ccls. and "common electrode" same "pixel electrode" same "source electrode" near10 hole	6/14/2005	LC
349/39,141 ccls. and electrode near10 electric adj field	6/15/2005	LC